

<b>Notice of References Cited</b>	Application/Control No. 10/813,637		Applicant(s)/Patent Under Reexamination JONES ET AL.	
	Examiner Derek L. Dupuis		Art Unit 2883	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0197013 A1	12-2002	Liu et al.	385/37
*	B	US-2005/0213880 A1	09-2005	Jones, Richard	385/030
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Wiesmann et al. "Large UV-induced negative index changes in germanium-free nitrogen-doped planar SiO2 waveguides." Electronics Letters. Vol 34, No 4. February 19th, 1998. pp 364-366
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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